

Notice of References Cited	Application/Control No. 10/763,276	Applicant(s)/Patent Under Reexamination SHIBUYA ET AL.	
	Examiner Peter J. Reddig	Art Unit 1642	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Takahashi et al. (EMBO J. 2001 20:2768-78)
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